

SN74ALVCH16600

18-BIT UNIVERSAL BUS TRANSCEIVER WITH 3-STATE OUTPUTS

SCES030E – JULY 1995 – REVISED MAY 2000

- Member of the Texas Instruments *Widebus*™ Family
- *EPIC*™ (Enhanced-Performance Implanted CMOS) Submicron Process
- *UBT*™ (Universal Bus Transceiver) Combines D-Type Latches and D-Type Flip-Flops for Operation in Transparent, Latched, Clocked, or Clock-Enabled Mode
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Package Options Include Plastic 300-mil Shrink Small-Outline (DL) and Thin Shrink Small-Outline (DGG) Packages

DGG OR DL PACKAGE
(TOP VIEW)

| | | | |
|-----------------|----|----|-----------------|
| OEAB | 1 | 56 | CLKENAB |
| LEAB | 2 | 55 | CLKAB |
| A1 | 3 | 54 | B1 |
| GND | 4 | 53 | GND |
| A2 | 5 | 52 | B2 |
| A3 | 6 | 51 | B3 |
| V _{CC} | 7 | 50 | V _{CC} |
| A4 | 8 | 49 | B4 |
| A5 | 9 | 48 | B5 |
| A6 | 10 | 47 | B6 |
| GND | 11 | 46 | GND |
| A7 | 12 | 45 | B7 |
| A8 | 13 | 44 | B8 |
| A9 | 14 | 43 | B9 |
| A10 | 15 | 42 | B10 |
| A11 | 16 | 41 | B11 |
| A12 | 17 | 40 | B12 |
| GND | 18 | 39 | GND |
| A13 | 19 | 38 | B13 |
| A14 | 20 | 37 | B14 |
| A15 | 21 | 36 | B15 |
| V _{CC} | 22 | 35 | V _{CC} |
| A16 | 23 | 34 | B16 |
| A17 | 24 | 33 | B17 |
| GND | 25 | 32 | GND |
| A18 | 26 | 31 | B18 |
| OEBA | 27 | 30 | CLKBA |
| LEBA | 28 | 29 | CLKENBA |

description

This 18-bit universal bus transceiver is designed for 1.65-V to 3.6-V V_{CC} operation.

The SN74ALVCH16600 combines D-type latches and D-type flip-flops to allow data flow in transparent, latched, and clocked modes.

Data flow in each direction is controlled by output-enable (\overline{OEAB} and \overline{OEBA}), latch-enable (LEAB and LEBA), and clock (\overline{CLKAB} and \overline{CLKBA}) inputs. The clock can be controlled by the clock-enable ($\overline{CLKENAB}$ and $\overline{CLKENBA}$) inputs. For A-to-B data flow, the device operates in the transparent mode when LEAB is high. When LEAB is low, the A data is latched if \overline{CLKAB} is held at a high or low logic level. If LEAB is low, the A data is stored in the latch/flip-flop on the high-to-low transition of \overline{CLKAB} . Output enable \overline{OEAB} is active low. When \overline{OEAB} is low, the outputs are active. When \overline{OEAB} is high, the outputs are in the high-impedance state.

Data flow for B to A is similar to that of A to B but uses \overline{OEBA} , LEBA, \overline{CLKBA} , and $\overline{CLKENBA}$.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

The SN74ALVCH16600 is characterized for operation from -40°C to 85°C.



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FUNCTION TABLE†

| INPUTS | | | | | OUTPUT B |
|-----------------------------|--------------------------|------|---------------------------|---|------------------|
| $\overline{\text{CLKENAB}}$ | $\overline{\text{OEAB}}$ | LEAB | $\overline{\text{CLKAB}}$ | A | |
| X | H | X | X | X | Z |
| X | L | H | X | L | L |
| X | L | H | X | H | H |
| H | L | L | X | X | B ₀ ‡ |
| H | L | L | X | X | B ₀ ‡ |
| L | L | L | ↓ | L | L |
| L | L | L | ↓ | H | H |
| L | L | L | H | X | B ₀ ‡ |
| L | L | L | L | X | B ₀ § |

† A-to-B data flow is shown; B-to-A flow is similar but uses $\overline{\text{OEBA}}$, LEBA, and CLKBA.

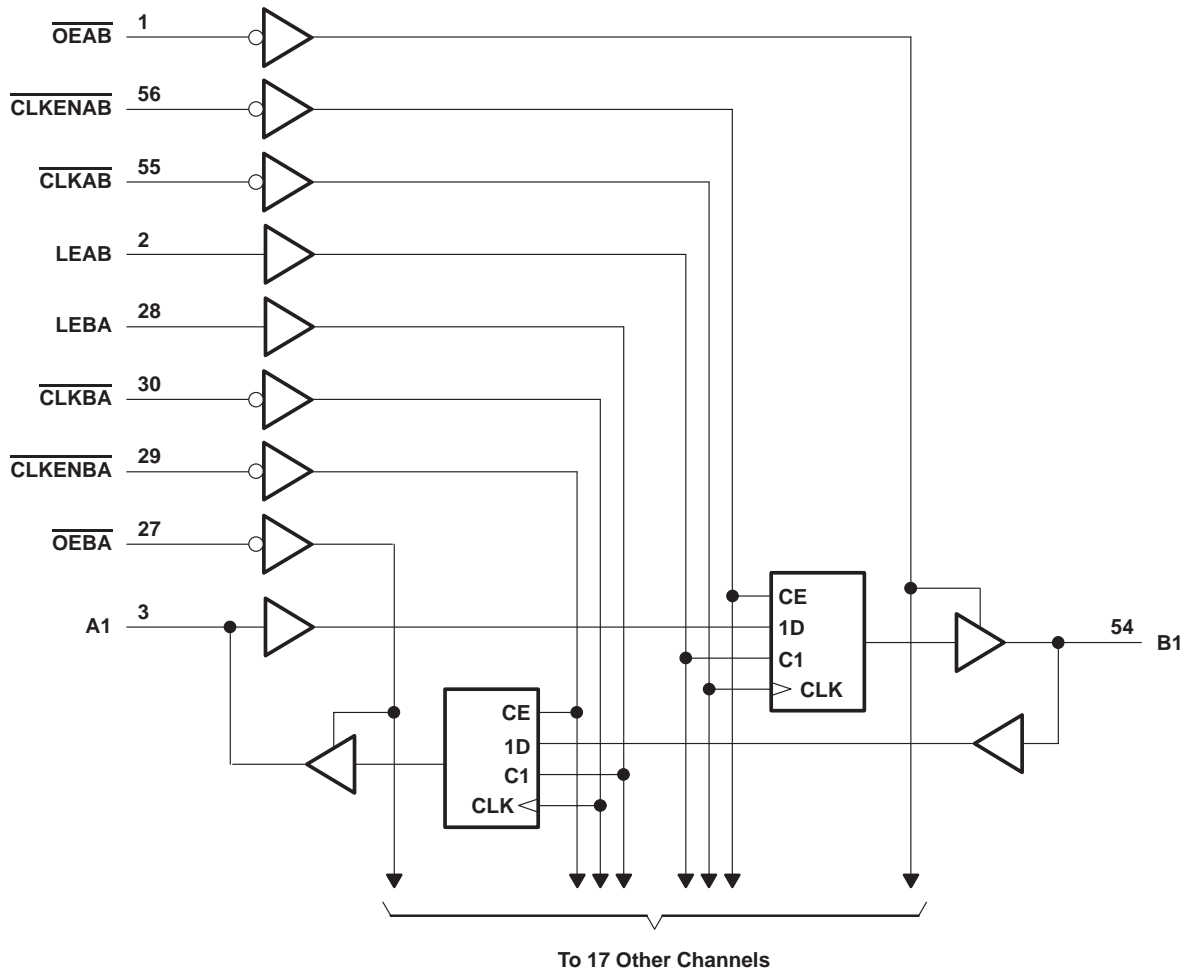
‡ Output level before the indicated steady-state input conditions were established, provided that CLKAB was high before LEAB went low

§ Output level before the indicated steady-state input conditions were established



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logic diagram (positive logic)



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

| | |
|--|----------------------------|
| Supply voltage range, V_{CC} | –0.5 V to 4.6 V |
| Input voltage range, V_I : Except I/O ports (see Note 1) | –0.5 V to 4.6 V |
| I/O ports (see Notes 1 and 2) | –0.5 V to $V_{CC} + 0.5$ V |
| Output voltage range, V_O (see Notes 1 and 2) | –0.5 V to $V_{CC} + 0.5$ V |
| Input clamp current, I_{IK} ($V_I < 0$) | –50 mA |
| Output clamp current, I_{OK} ($V_O < 0$) | –50 mA |
| Continuous output current, I_O | ±50 mA |
| Continuous current through each V_{CC} or GND | ±100 mA |
| Package thermal impedance, θ_{JA} (see Note 3): DGG package | 64°C/W |
| DL package | 56°C/W |
| Storage temperature range, T_{stg} | –65°C to 150°C |

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.
2. This value is limited to 4.6 V maximum.
3. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 4)

| | | MIN | MAX | UNIT |
|---------------------|------------------------------------|-----------------------------|----------------------|------|
| V_{CC} | Supply voltage | 1.65 | 3.6 | V |
| V_{IH} | High-level input voltage | $V_{CC} = 1.65$ V to 1.95 V | $0.65 \times V_{CC}$ | V |
| | | $V_{CC} = 2.3$ V to 2.7 V | 1.7 | |
| | | $V_{CC} = 2.7$ V to 3.6 V | 2 | |
| V_{IL} | Low-level input voltage | $V_{CC} = 1.65$ V to 1.95 V | $0.35 \times V_{CC}$ | V |
| | | $V_{CC} = 2.3$ V to 2.7 V | 0.7 | |
| | | $V_{CC} = 2.7$ V to 3.6 V | 0.8 | |
| V_I | Input voltage | 0 | V_{CC} | V |
| V_O | Output voltage | 0 | V_{CC} | V |
| I_{OH} | High-level output current | $V_{CC} = 1.65$ V | –4 | mA |
| | | $V_{CC} = 2.3$ V | –12 | |
| | | $V_{CC} = 2.7$ V | –12 | |
| | | $V_{CC} = 3$ V | –24 | |
| I_{OL} | Low-level output current | $V_{CC} = 1.65$ V | 4 | mA |
| | | $V_{CC} = 2.3$ V | 12 | |
| | | $V_{CC} = 2.7$ V | 12 | |
| | | $V_{CC} = 3$ V | 24 | |
| $\Delta t/\Delta v$ | Input transition rise or fall rate | | 10 | ns/V |
| T_A | Operating free-air temperature | –40 | 85 | °C |

NOTE 4: All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP† | MAX | UNIT |
|--------------------------|--|---|----------------------|------|------|------|
| V _{OH} | I _{OH} = -100 μA | 1.65 V to 3.6 V | V _{CC} -0.2 | | | V |
| | I _{OH} = -4 mA | 1.65 V | 1.2 | | | |
| | I _{OH} = -6 mA | 2.3 V | 2 | | | |
| | I _{OH} = -12 mA | 2.3 V | 1.7 | | | |
| | | 2.7 V | 2.2 | | | |
| | | 3 V | 2.4 | | | |
| I _{OH} = -24 mA | 3 V | 2 | | | | |
| V _{OL} | I _{OL} = 100 μA | 1.65 V to 3.6 V | | | 0.2 | V |
| | I _{OL} = 4 mA | 1.65 V | | | 0.45 | |
| | I _{OL} = 6 mA | 2.3 V | | | 0.4 | |
| | I _{OL} = 12 mA | 2.3 V | | | 0.7 | |
| | | 2.7 V | | | 0.4 | |
| | I _{OL} = 24 mA | 3 V | | | 0.55 | |
| I _I | V _I = V _{CC} or GND | 3.6 V | | | ±5 | μA |
| I _I (hold) | V _I = 0.58 V | 1.65 V | | 25 | | μA |
| | V _I = 1.07 V | 1.65 V | | -25 | | |
| | V _I = 0.7 V | 2.3 V | | 45 | | |
| | V _I = 1.7 V | 2.3 V | | -45 | | |
| | V _I = 0.8 V | 3 V | | 75 | | |
| | V _I = 2 V | 3 V | | -75 | | |
| | V _I = 0 to 3.6 V‡ | 3.6 V | | | ±500 | |
| I _{OZ} § | V _O = V _{CC} or GND | 3.6 V | | | ±10 | μA |
| I _{CC} | V _I = V _{CC} or GND, I _O = 0 | 3.6 V | | | 40 | μA |
| ΔI _{CC} | One input at V _{CC} - 0.6 V, Other inputs at V _{CC} or GND | 3 V to 3.6 V | | | 750 | μA |
| C _i | Control inputs | V _I = V _{CC} or GND | 3.3 V | | 4 | pF |
| C _{io} | A or B ports | V _O = V _{CC} or GND | 3.3 V | | 8 | pF |

† All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

‡ This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.

§ For I/O ports, the parameter I_{OZ} includes the input leakage current.



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timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

| | | V _{CC} = 1.8 V | | V _{CC} = 2.5 V ± 0.2 V | | V _{CC} = 2.7 V | | V _{CC} = 3.3 V ± 0.3 V | | UNIT | |
|--------------------|-----------------|-------------------------|----------|------------------------------------|-----|-------------------------|-----|------------------------------------|-----|------|-----|
| | | MIN | MAX | MIN | MAX | MIN | MAX | MIN | MAX | | |
| f _{clock} | Clock frequency | † | | 150 | | 150 | | 150 | | MHz | |
| t _w | Pulse duration | LE high | | † | | 3.3 | | 3.3 | | ns | |
| | | CLK high or low | | † | | 3.3 | | 3.3 | | | |
| t _{su} | Setup time | Data before CLK↑ | | † | | 1.3 | | 1.3 | | ns | |
| | | Data before LE↓ | CLK high | | † | | 1.2 | | 1.1 | | |
| | | | CLK low | | † | | 1.8 | | 1.5 | | |
| | | CLKEN before CLK↑ | | † | | 0.7 | | 0.7 | | | 0.8 |
| t _h | Hold time | Data after CLK↑ | | † | | 1.5 | | 1.8 | | ns | |
| | | Data after LE↓ | CLK high | | † | | 1.6 | | 1.9 | | |
| | | | CLK low | | † | | 1.2 | | 1.6 | | |
| | | CLKEN after CLK↑ | | † | | 1.4 | | 1.7 | | | 1.4 |

† This information was not available at the time of publication.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | V _{CC} = 1.8 V | | V _{CC} = 2.5 V ± 0.2 V | | V _{CC} = 2.7 V | | V _{CC} = 3.3 V ± 0.3 V | | UNIT |
|------------------|-----------------|----------------|-------------------------|-----|------------------------------------|-----|-------------------------|-----|------------------------------------|-----|------|
| | | | MIN | TYP | MIN | MAX | MIN | MAX | MIN | MAX | |
| f _{max} | | | † | | 150 | | 150 | | 150 | | MHz |
| t _{pd} | A or B | B or A | † | | 1 | 5.1 | 4.7 | | 1 | 4 | ns |
| | LEAB or LEBA | A or B | † | | 1 | 5.9 | 5.5 | | 1 | 4.8 | |
| | CLKAB or CLKBA | | † | | 1 | 7.3 | 6.8 | | 1.3 | 5.7 | |
| t _{en} | OEAB or OEBA | A or B | † | | 1 | 6.5 | 6.3 | | 1.1 | 5.2 | ns |
| t _{dis} | OEAB or OEBA | A or B | † | | 1 | 5.1 | 4.7 | | 1.2 | 4.4 | ns |

† This information was not available at the time of publication.

operating characteristics, T_A = 25°C

| PARAMETER | | TEST CONDITIONS | V _{CC} = 1.8 V | V _{CC} = 2.5 V | V _{CC} = 3.3 V | UNIT |
|-----------------|-------------------------------|------------------------------------|-------------------------|-------------------------|-------------------------|------|
| | | | TYP | TYP | TYP | |
| C _{pd} | Power dissipation capacitance | C _L = 50 pF, f = 10 MHz | † | 43 | 56 | pF |
| | Outputs enabled | | † | 6 | 6 | |
| | Outputs disabled | | † | | | |

† This information was not available at the time of publication.

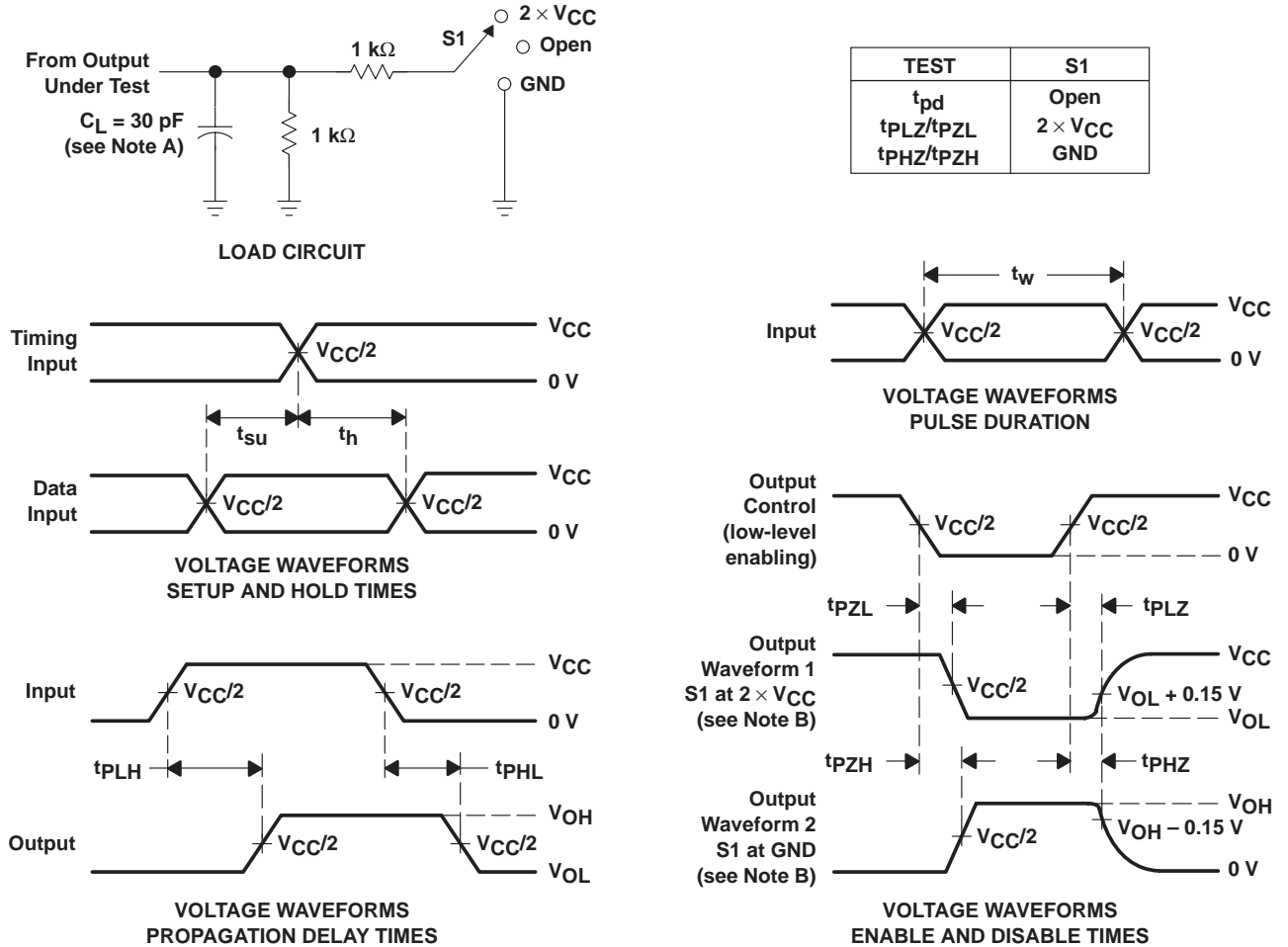


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PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 1.8\text{ V}$



- NOTES:
- A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: $PRR \leq 10\text{ MHz}$, $Z_O = 50\ \Omega$, $t_r \leq 2\text{ ns}$, $t_f \leq 2\text{ ns}$.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. t_{PLH} and t_{PHL} are the same as t_{pd} .

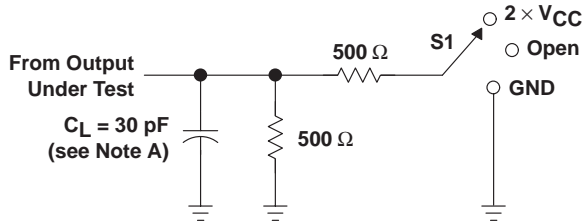
Figure 1. Load Circuit and Voltage Waveforms

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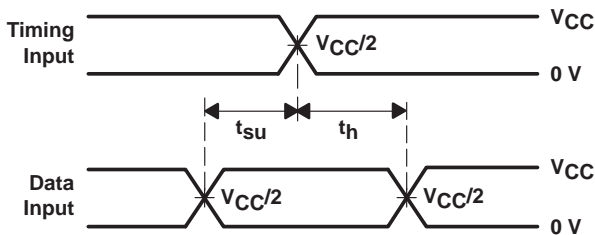
PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 2.5 V \pm 0.2 V$

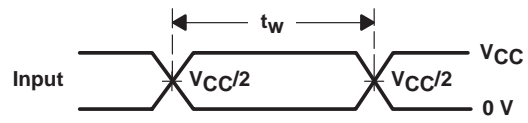


LOAD CIRCUIT

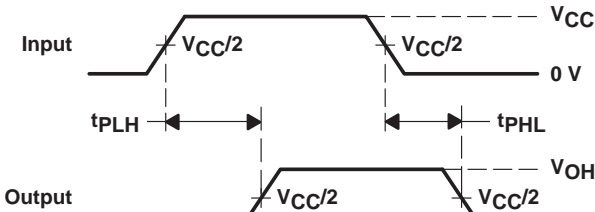
| TEST | S1 |
|-------------------|-------------------|
| t_{pd} | Open |
| t_{PLZ}/t_{PZL} | $2 \times V_{CC}$ |
| t_{PHZ}/t_{PZH} | GND |



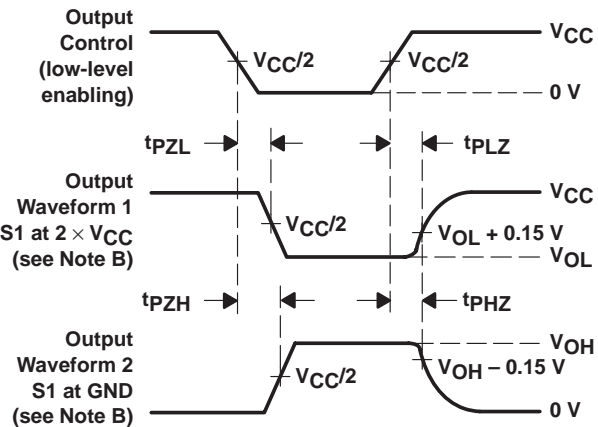
**VOLTAGE WAVEFORMS
 SETUP AND HOLD TIMES**



**VOLTAGE WAVEFORMS
 PULSE DURATION**



**VOLTAGE WAVEFORMS
 PROPAGATION DELAY TIMES**



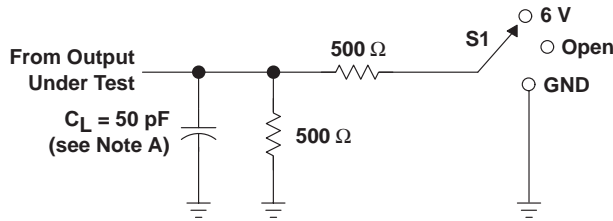
**VOLTAGE WAVEFORMS
 ENABLE AND DISABLE TIMES**

- NOTES:
- A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: $PRR \leq 10 \text{ MHz}$, $Z_O = 50 \Omega$, $t_r \leq 2 \text{ ns}$, $t_f \leq 2 \text{ ns}$.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 2. Load Circuit and Voltage Waveforms

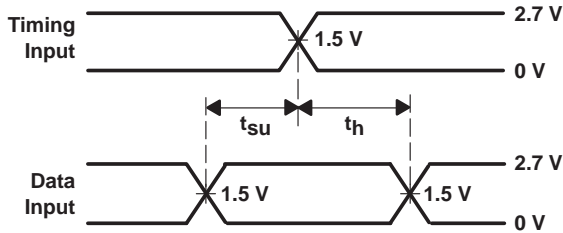
PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 2.7\text{ V AND } 3.3\text{ V} \pm 0.3\text{ V}$

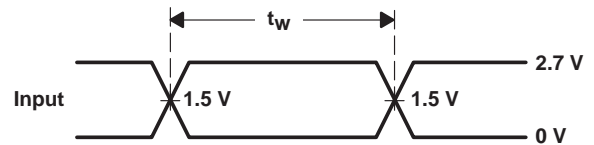


LOAD CIRCUIT

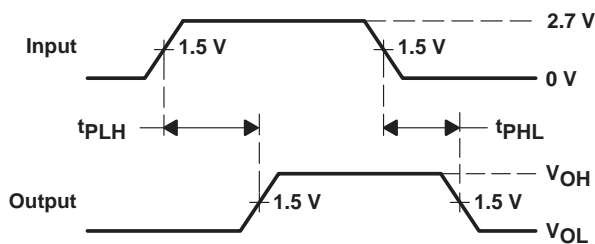
| TEST | S1 |
|-------------------|------|
| t_{pd} | Open |
| t_{PLZ}/t_{PZL} | 6 V |
| t_{PHZ}/t_{PHL} | GND |



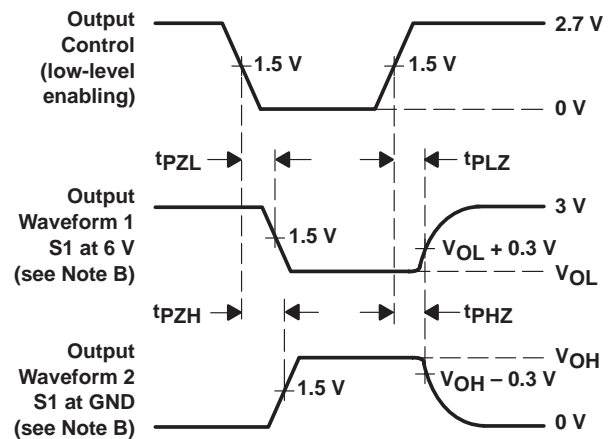
**VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES**



**VOLTAGE WAVEFORMS
PULSE DURATION**



**VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES**



**VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES**

- NOTES: A. C_L includes probe and jig capacitance.
 B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: $PRR \leq 10\text{ MHz}$, $Z_O = 50\ \Omega$, $t_r \leq 2.5\text{ ns}$, $t_f \leq 2.5\text{ ns}$.
 D. The outputs are measured one at a time with one transition per measurement.
 E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 F. t_{PZL} and t_{PZH} are the same as t_{en} .
 G. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 3. Load Circuit and Voltage Waveforms

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